

Notice of References Cited	Application/Control No. 10/811,974	Applicant(s)/Patent Under Reexamination TANI ET AL.	
	Examiner John P. Leubecker	Art Unit 3739	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,523,786	06-1996	Parulski, Kenneth A.	348/269
*	B	US-2004/0263645	12-2004	Okada et al.	348/231.99
*	C	US-2003/0164441	09-2003	Lyon et al.	250/208.1
*	D	US-6,821,245	11-2004	Cline et al.	600/160
*	E	US-2004/0012688	01-2004	Tinnerino et al.	348/218.1
*	F	US-6,529,768	03-2003	Hakamata, Kazuo	600/476
*	G	US-5,394,187	02-1995	Shipp, John I.	348/269
*	H	US-5,827,190	10-1998	Palcic et al.	600/476
*	I	US-6,888,568	05-2005	Neter, Sarit	348/222.1
*	J	US-2003/0133028	07-2003	Morinaka et al.	348/273
*	K	US-6,999,119	02-2006	Shibazaki et al.	348/273
*	L	US-5,485,204	01-1996	Taniji, Yukio	348/264
*	M	US-5,278,660	01-1994	Sugiki, Tadashi	348/305

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.